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TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

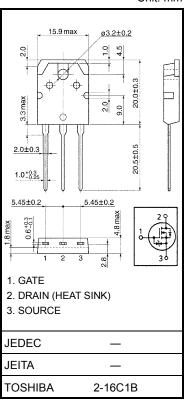
2SK2749

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- Low drain-source ON resistance $: RDS (ON) = 1.6 \Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 5.0 \text{ S (typ.)}$
- Low leakage current $: IDSS = 100 \ \mu A \ (max) \ (VDS = 720 \ V)$
- Enhancement mode : $V_{th} = 2.0 \sim 4.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ ID} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	900	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	900	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	7	А	
	Pulse (Note 1)	I _{DP}	21	A	
Drain power dissipatio	n (Tc = 25°C)	PD	150	W	
Single pulse avalanche energy (Note 2)		E _{AS}	682	mJ	
Avalanche current		I _{AR}	7	А	
Repetitive avalanche energy (Note 3)		E _{AR}	15	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 4.6 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.833	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	50	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 25.5 mH, I_{AR} = 7 A, R_G = 25 Ω

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



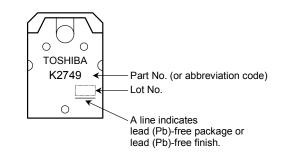
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	ent I _{GSS} V _{GS} = ±25 V, V _{DS} = 0 V			—	±10	μA
Gate-source br	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V	±30	_	_	V
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V		_	100	μA
Drain-source br	reakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	900	_	_	V
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 3.5 A		1.6	2.0	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3.5 A	1.25	5.0	_	S
Input capacitand	ce	C _{iss}			1500	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	30	_	
Output capacitance		C _{oss}			140	_	
Switching time	Rise time	tr	$V_{GS} \xrightarrow{10V}_{0V} \xrightarrow{I_D=3.5A}_{0VOUT}$	_	35	_	- ns
	Turn-on time	t _{on}			80	_	
	Fall time	t _f		_	50	_	
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w =10 μ s	_	220	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	55	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 400 V, V _{GS} = 10 V, I _D = 7 A		30	_	nC
Gate-drain ("miller") Charge		Q _{gd}			25	—	

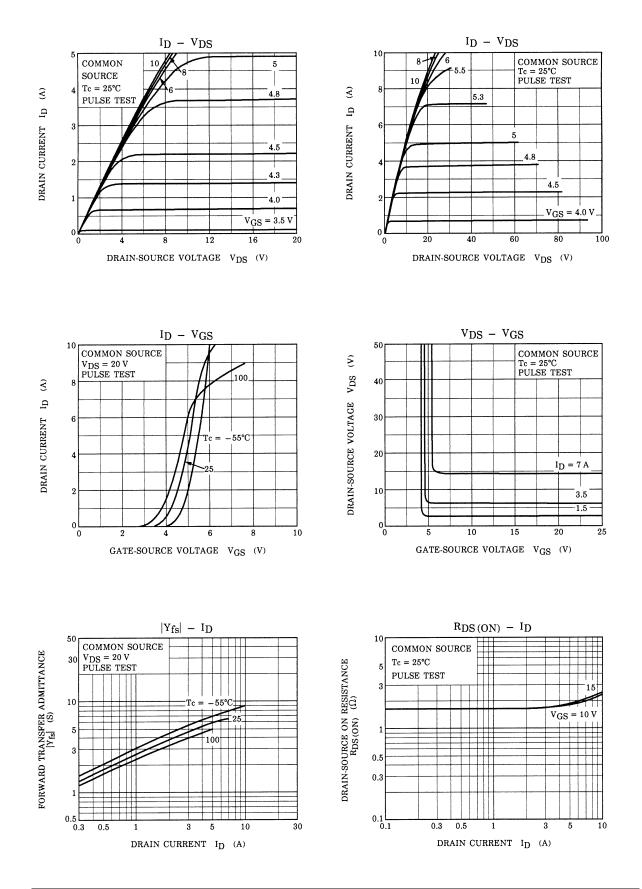
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	7	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	21	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 7 A, V _{GS} = 0 V	-	_	-1.9	V
Reverse recovery time	t _{rr}	I _{DR} = 7 A, V _{GS} = 0 V dI _{DR} / dt = 100 A / μs		1400		ns
Reverse recovery charge	Q _{rr}	dI _{DR} / dt = 100 A / μs	_	14		μC

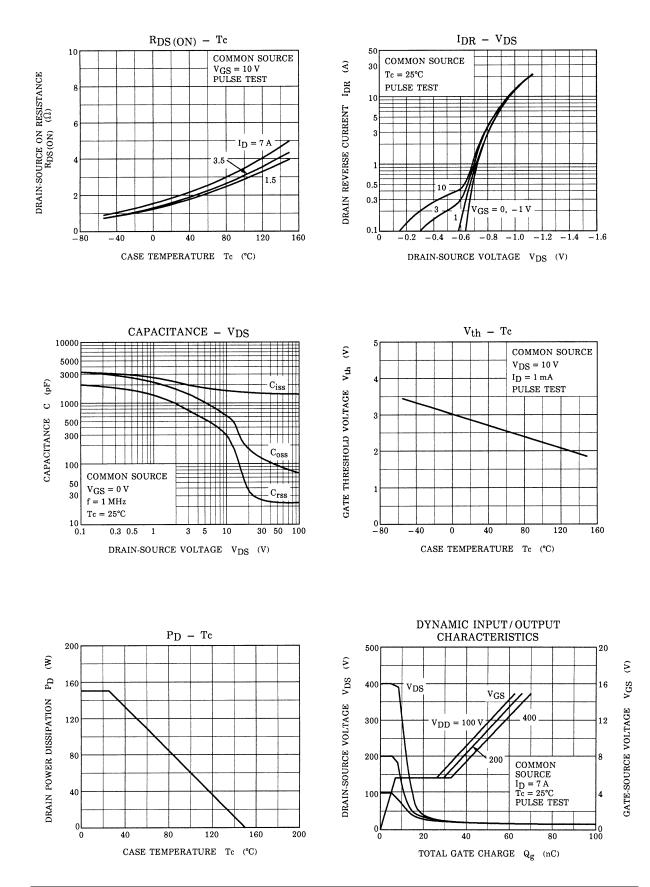
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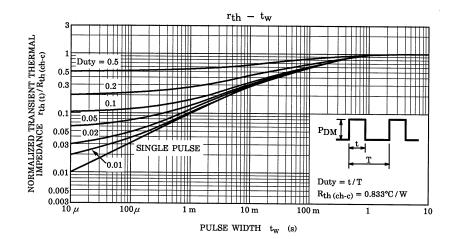


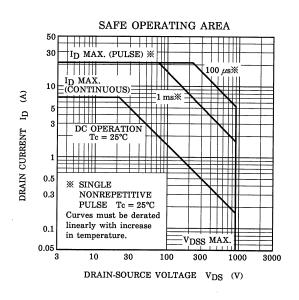
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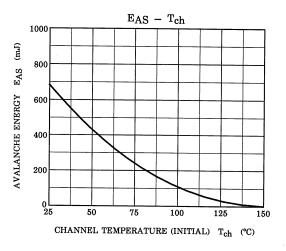


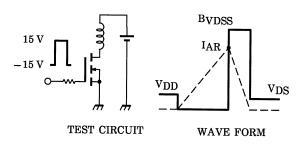
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$$\begin{array}{ll} \mathrm{R_{G}=25\ \Omega} \\ \mathrm{V_{DD}=90\ V,\ L=25.5\ mH} \end{array} \quad \quad \mathrm{E_{AS}=\frac{1}{2}\cdot L\cdot I^{2}\cdot \left(\frac{\mathrm{B_{VDSS}}}{\mathrm{B_{VDSS}-V_{DD}}}\right) } \end{array}$$

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